Product data sheet

1. Product profile

1.1 General description

The BGU8053 is a low noise high linearity amplifier for wireless infrastructure applications, equipped with fast shutdown to support TDD systems. The LNA has a high input and output return loss and is designed to operate between 2 GHz and 4 GHz. It is housed in a 2 mm \times 2 mm \times 0.75 mm 8-terminal plastic thin small outline package. The LNA is ESD protected on all terminals.

1.2 Features and benefits

- Low noise performance: NF = 0.56 dB
- High linearity performance: IP3_O = 36 dBm
- High input return loss > 12 dB
- High output return loss > 20 dB
- Unconditionally stable up to 20 GHz
- Programmable bias current (via resistor)
- Small 8-terminal leadless package 2 mm × 2 mm × 0.75 mm
- ESD protection on all terminals
- Moisture sensitivity level 1
- Fast shutdown to support TDD systems
- +5 V single supply

1.3 Applications

- Wireless infrastructure
- Low noise and high linearity applications
- LTE, W-CDMA, CDMA, GSM
- General purpose wireless applications
- TDD or FDD systems
- Suitable for small cells



Low noise high linearity amplifier

1.4 Quick reference data

Table 1. Quick reference data

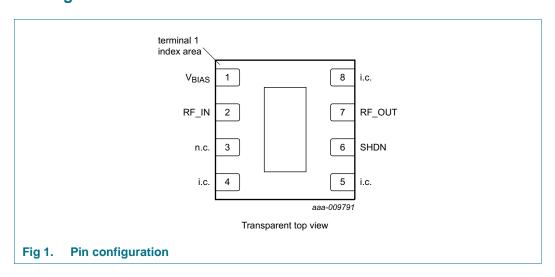
f = 2500 MHz; $V_{CC} = 5$ V; $T_{amb} = 25$ °C; input and output 50 Ω ; Rbias = 5.1 k Ω ; unless otherwise specified. All RF parameters are measured in an application board as shown in Figure 15 with components listed in Table 9 optimized for f = 2500 MHz.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I_{CC}	supply current	on state		36	48	60	mA
		off state		-	2.8	-	mA
G _{ass}	associated gain	on state		17	18.5	20	dB
		off state		-	-23.5	-	dB
NF	noise figure		[1]	-	0.56	0.75	dB
P _{L(1dB)}	output power at 1 dB gain compression			-	18	-	dBm
IP3 _O	output third-order intercept point	2-tone; tone spacing = 1 MHz; P _i = -15 dBm per tone		32	36	-	dBm

^[1] Connector and Printed-Circuit Board (PCB) losses have been de-embedded.

2. Pinning information

2.1 Pinning



2.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
V_{BIAS}	1	bias voltage
RF_IN	2	RF input
n.c.	3	not connected
i.c.	4, 5, 8	internally connected. Can be grounded or left open in the application
SHDN	6	shutdown
RF_OUT	7	RF output
GND	exposed die pad	ground

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3. Ordering information

Table 3. Ordering information

Type number	Package							
	Name	Description	Version					
BGU8053	HWSON8	plastic thermal enhanced very very thin small outline package; no leads; 8 terminals; body $2 \times 2 \times 0.75$ mm	SOT1327-1					

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CC}	supply voltage			-	6	V
$V_{ctrl(sd)}$	shutdown control voltage			-	3	V
I _{CC}	supply current			-	85	mΑ
$P_{i(RF)CW}$	continuous waveform RF input power			-	20	dBm
T _{stg}	storage temperature			-40	+150	°C
Tj	junction temperature			-	150	°C
Р	power dissipation	T _{case} ≤ 125 °C	[1]	-	510	mW
V_{ESD}	electrostatic discharge voltage	Human Body Model (HBM) According to ANSI/ESDA/JEDEC standard JS-001-2010		-	0.9	kV
		Charged Device Model (CDM); According JEDEC standard 22-C101B		-	2	kV

^[1] Case is ground solder pad.

5. Recommended operating conditions

Table 5. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CC}	supply voltage		4.75	5	5.25	V
Z_0	characteristic impedance		-	50	-	Ω
T _{case}	case temperature		-40	-	+85	°C

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	T	ур	Unit
R _{th(j-case)}	thermal resistance from junction to case		[1][2] 5	0	K/W

^[1] Case is ground solder pad.

^[2] Thermal resistance measured using infrared measurement technique, device mounted on application board and placed in still air.

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7. Characteristics

Table 7. Characteristics

f = 2500 MHz; $V_{CC} = 5$ V; $T_{amb} = 25$ °C; input and output 50 Ω ; Rbias = 5.1 k Ω ; unless otherwise specified. All RF parameters are measured in an application board as shown in Figure 15 with components listed in Table 9 optimized for f = 2500 MHz.

$\begin{array}{lll} I_{CC} & \text{supply current} & & \text{on state} \\ \hline off state & & \\ G_{ass} & \text{associated gain} & & \text{on state} \\ \hline NF & \text{noise figure} & & & \underline{11} \\ \end{array}$	36 - 17	48 2.8 18.5	60 -	mA mA
G _{ass} associated gain on state off state			-	mΑ
off state		10.5		
		10.5	20	dB
NF noise figure [1]	-	-23.5	-	dB
	-	0.56	0.75	dB
P _{L(1dB)} output power at 1 dB gain compression	-	18	-	dBm
IP3 _O output third-order intercept point 2-tone; tone spacing = 1 MHz; $P_i = -15$ dBm per tone	32	36	-	dBm
2-tone; tone spacing = 1 MHz; [2] P _i = -15 dBm per tone	30	34	-	dBm
RL _{in} input return loss on state	-	12.2	-	dB
off state	-	6.3	-	dB
RL _{out} output return loss	-	28.0	-	dB
ISL isolation	-	22.0	-	dB
$t_{s(pon)}$ power-on settling time $P_i = -20$ dBm; SHDN (pin 6) from HIGH to LOW [2]	-	1.4	-	μS
$t_{s(poff)}$ power-off settling time $P_i = -20$ dBm; SHDN (pin 6) from LOW to HIGH [2]	-	0.4	-	μS
K Rollett stability factor both on state and off state up to f = 20 GHz	1	-	-	
R _{pd(SHDN)} pull-down resistance on pin SHDN	-	30	-	kΩ

^[1] Connector and Printed-Circuit Board (PCB) losses have been de-embedded.

Table 8. Shutdown control

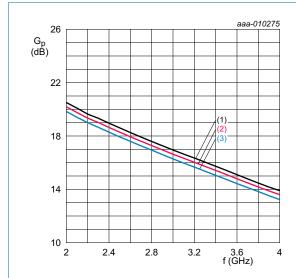
 $V_{CC} = 5 \ V$; $T_{amb} = 25 \ ^{\circ}\text{C}$; input and output $50 \ \Omega$; Rbias = $5.1 \ \text{k}\Omega$; unless otherwise specified. All RF parameters are measured in an application board as shown in <u>Figure 15</u> with components listed in <u>Table 9</u> optimized for $f = 2500 \ \text{MHz}$.

State	V _{ctrl(sd)} [1] (V)
on state	≤ 0.6
off state	≥ 1.2

^[1] Voltage on pin 6 (SHDN).

^[2] For TDD systems where fast switching is required, it is recommended to change C1 and C2 to 100 pF.

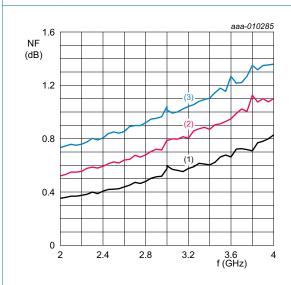
7.1 Graphs



$$V_{CC} = 5 \text{ V}$$
; $I_{CC} = 48 \text{ mA}$.

- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = +25 \, ^{\circ}C$
- (3) $T_{amb} = +85 \, ^{\circ}C$

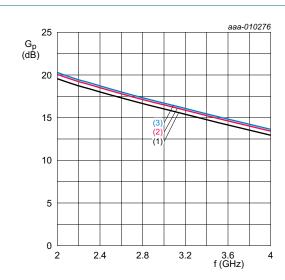
Fig 2. Power gain as a function of frequency; typical values



$$V_{CC} = 5 \text{ V}; I_{CC} = 48 \text{ mA}.$$

- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = +25 \, ^{\circ}C$
- (3) $T_{amb} = +85 \, ^{\circ}C$

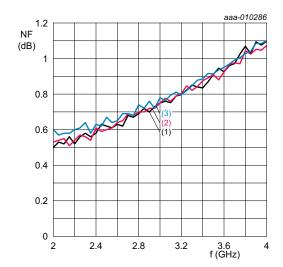
Fig 4. Noise figure as a function of frequency; typical values



$$V_{CC} = 5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}.$$

- (1) $I_{CC} = 30 \text{ mA}$
- (2) $I_{CC} = 45 \text{ mA}$
- (3) $I_{CC} = 60 \text{ mA}$

Fig 3. Power gain as a function of frequency; typical values

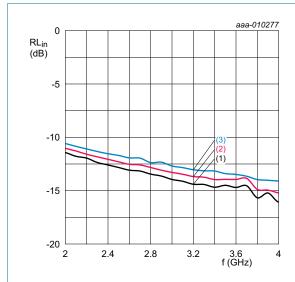


$$V_{CC} = 5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}.$$

- (1) $I_{CC} = 30 \text{ mA}$
- (2) $I_{CC} = 45 \text{ mA}$
- (3) $I_{CC} = 60 \text{ mA}$

Fig 5. Noise figure as a function of frequency; typical values

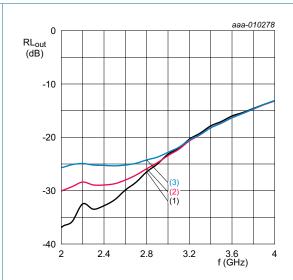
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$$V_{CC}$$
 = 5 V; I_{CC} = 48 mA.

- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = +25 \, ^{\circ}C$
- (3) $T_{amb} = +85 \, ^{\circ}C$

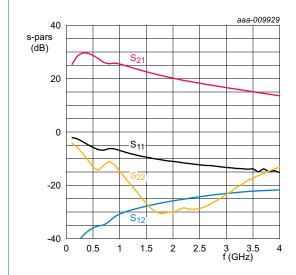
Fig 6. Input return loss as a function of frequency; typical values



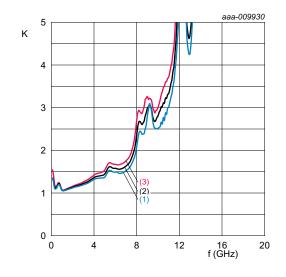
$$V_{CC} = 5 \text{ V}; I_{CC} = 48 \text{ mA}.$$

- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = +25 \, ^{\circ}C$
- (3) $T_{amb} = +85 \, ^{\circ}C$

Fig 7. Output return loss as a function of frequency; typical values



 V_{CC} = 5 V; T_{amb} = 25 °C; I_{CC} = 48 mA.



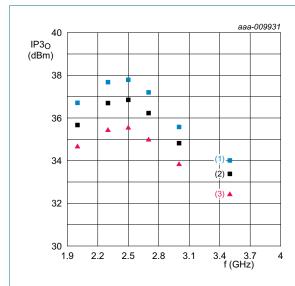
 $V_{CC} = 5 \text{ V}; I_{CC} = 48 \text{ mA}.$

- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = +25 \, ^{\circ}C$
- (3) $T_{amb} = +85 \, ^{\circ}C$

Fig 9. Rollet stability factor as a function of frequency; typical values

Fig 8. Wideband S-parameters as function of frequency; typical values

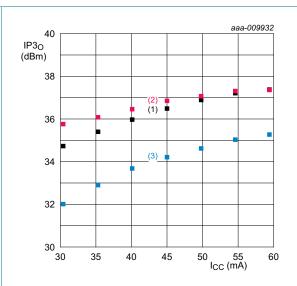
Low noise high linearity amplifier



 V_{CC} = 5 V; P_i = -15 dBm per tone; I_{CC} = 48 mA.

- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = +25 \, ^{\circ}C$
- (3) $T_{amb} = +85 \, ^{\circ}C$

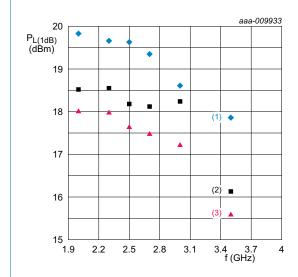
Fig 10. Output third-order intercept point as a function of frequency; typical values



 $V_{CC} = 5 \text{ V}$; $P_i = -15 \text{ dBm per tone}$; $T_{amb} = 25 \,^{\circ}\text{C}$.

- (1) f = 2000 MHz
- (2) f = 2500 MHz
- (3) f = 3000 MHz

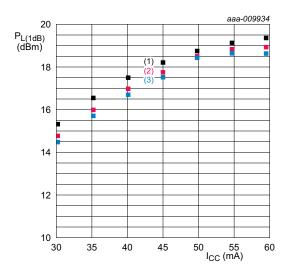
Fig 11. Output third-order intercept point as a function of supply current; typical values



 $V_{CC} = 5 \text{ V}; I_{CC} = 48 \text{ mA}.$

- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = +25 \, ^{\circ}C$
- (3) $T_{amb} = +85 \, ^{\circ}C$

Fig 12. Output power at 1 dB gain compression as a function of frequency; typical values

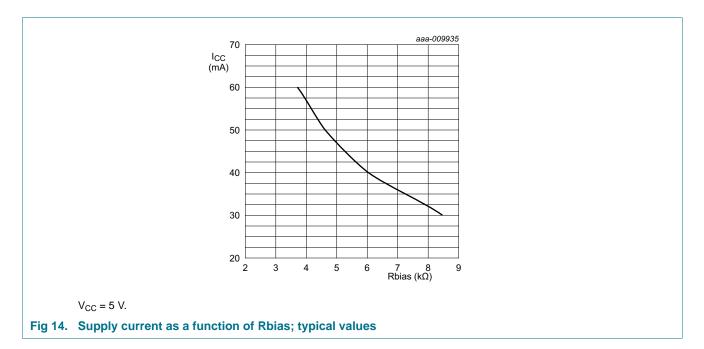


 $V_{CC} = 5 \text{ V}$; $T_{amb} = 25 \,^{\circ}\text{C}$.

- (1) f = 2000 MHz
- (2) f = 2500 MHz
- (3) f = 3000 MHz

Fig 13. Output power at 1 dB gain compression as a function of supply current; typical values

Low noise high linearity amplifier



8. Application information

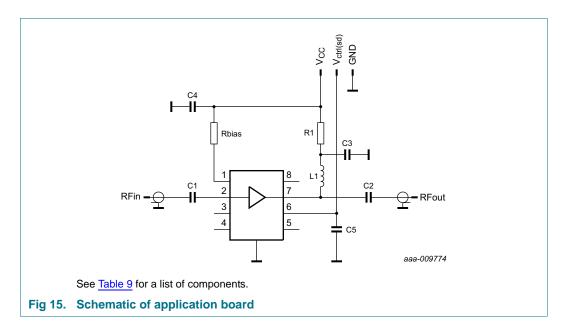


Table 9. List of components See Figure 15 for schematics.

Component	Description	Value	Remarks
C1, C2	capacitor	100 nF	
		100 pF	recommended for TDD systems
C3, C5	capacitor	10 pF	
C4	capacitor	10 nF	

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Table 9. List of components ...continued See Figure 15 for schematics.

Component	Description	Value	Remarks	
L1	inductor	15 nH		
R1	resistor	10 Ω		
Rbias	resistor	5.1 kΩ		

Table 10. Typical performance BGU8053 application board

All RF parameters are measured at the application board as shown in <u>Figure 15</u> with the components as listed in <u>Table 9</u> while optimized for: f = 2500 MHz; $V_{CC} = 5$ V; $I_{CC} = 48$ mA and $T_{amb} = 25$ °C.

Symbol	Parameter		f (MH	z)						
			2000	2300	2500	2700	3000	3400	3500	3800
G _{ass}	associated gain		20.2	19.0	18.3	17.6	16.6	15.4	15.1	14.2
RLin	input return loss		11.0	11.8	12.3	12.6	13.3	14.0	13.8	14.9
RL_{out}	output return loss		30.1	28.9	28.7	27.1	23.4	18.2	17.3	14.7
P _{L(1dB)}	output power at 1 dB gain compression		18.5	18.6	18.2	18.1	18.2	16.4	16.1	14.4
IP3 _O	output third-order intercept	<u>[1]</u>	35.7	36.7	36.8	36.2	34.8	36.2	33.4	33.0
	point	[1][2]	34.9	35.9	34.5	36.0	32.1	35.3	31.7	31.6
NF	noise figure	[3]	0.52	0.59	0.63	0.68	0.79	0.81	0.83	0.96

^{[1] 2-}Tone; tone spacing = 1 MHz; $P_i = -15$ dBm per tone.

^[2] For TDD systems C1 and C2 have to be 100 pF.

^[3] Connector and board losses not de-embedded.

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9. Package outline

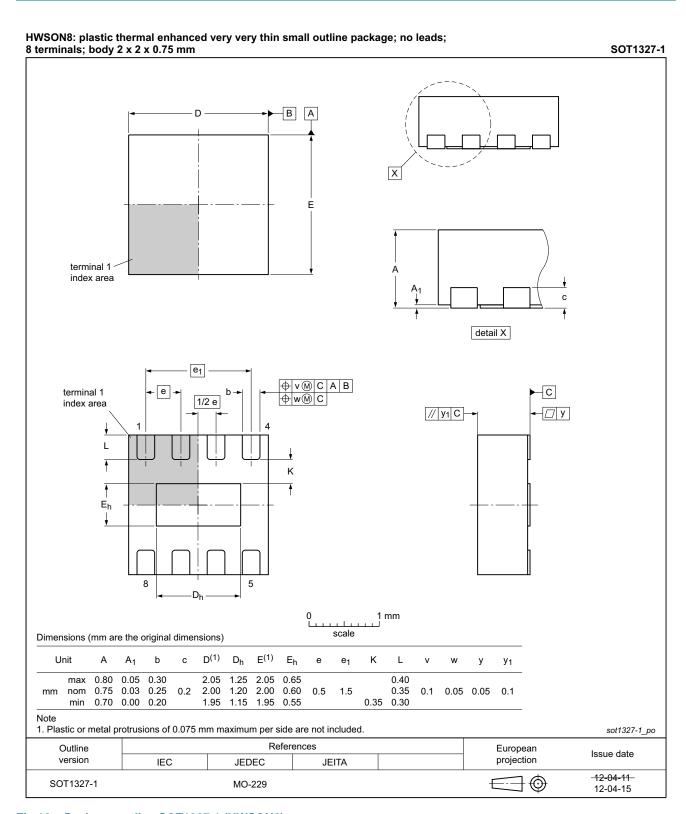


Fig 16. Package outline SOT1327-1 (HWSON8)

Low noise high linearity amplifier

10. Abbreviations

Table 11. Abbreviations

Acronym	Description
CDMA	Code Division Multiple Access
ESD	ElectroStatic Discharge
FDD	Frequency-Division Duplexing
GSM	Global System for Mobile Communication
LNA	Low Noise Amplifier
LTE	Long Term Evolution
RF	Radio Frequency
TDD	Time-Division Duplexing
W-CDMA	Wideband Code Division Multiple Access

11. Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BGU8053 v.2	20131230	Product data sheet	-	BGU8053 v.1	
Modifications:	 <u>Table 4 on page 3</u>: The maximum value for V_{ctrl(sd)} has been corrected to 3 V. 				
BGU8053 v.1	20131127	Product data sheet	-	-	

Low noise high linearity amplifier

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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